

**GENERAL  
INSTRUMENT**

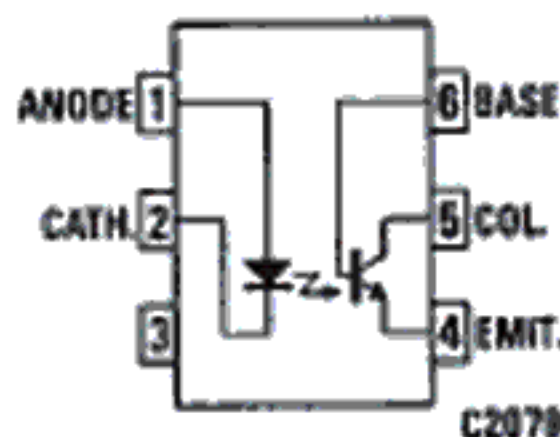
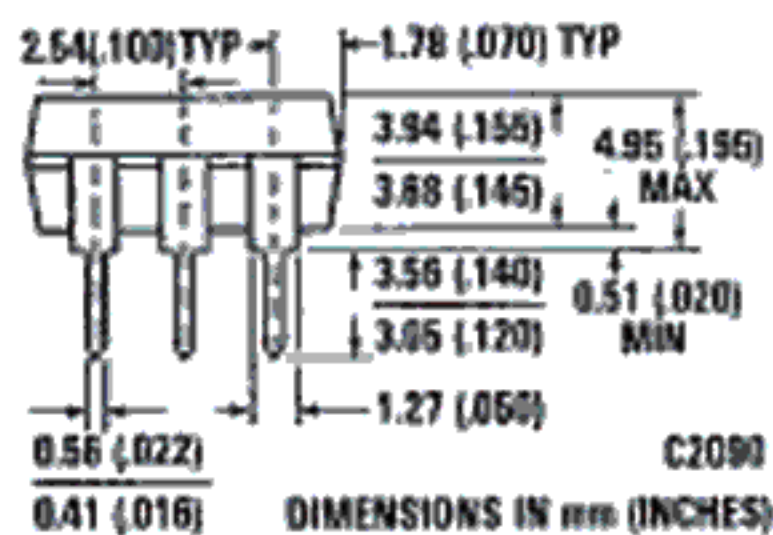
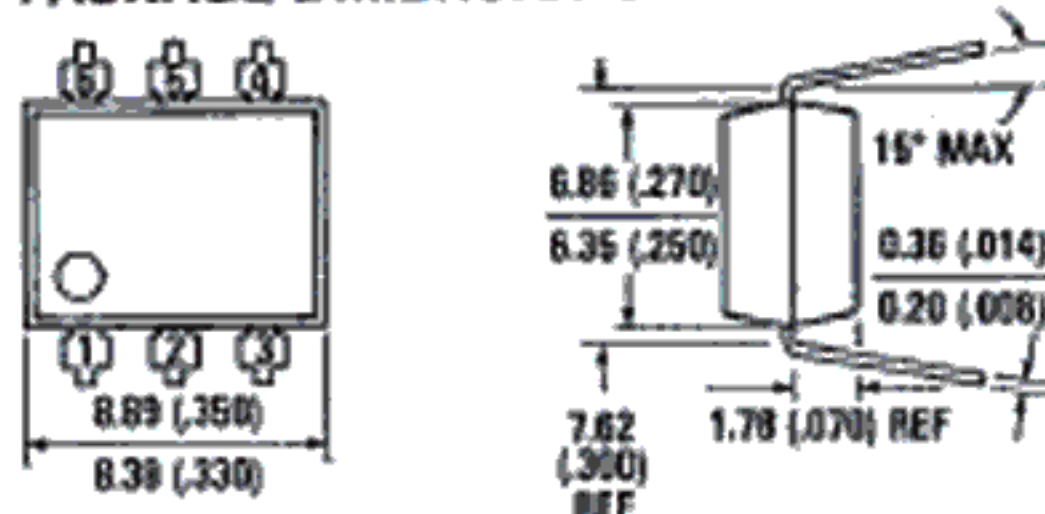
**VDE APPROVED  
TRANSISTOR OUTPUT OPTOCOUPLER**

Optocouplers



**H11A1  
H11A1Z**

**PACKAGE DIMENSIONS**



Equivalent Circuit

**DESCRIPTION**

The H11A1 is a phototransistor-type optically coupled isolator. An infrared emitting diode manufactured from specially grown gallium arsenide is selectively coupled with an NPN silicon phototransistor in a standard plastic six-pin dual-in-line package.

**FEATURES**

- High isolation voltage  
5300 VAC RMS — 5 seconds  
7500 VAC PEAK — 5 seconds
- Minimum current transfer ratio of 50%
- Underwriters Laboratory (UL) recognized File #E50151
- VDE approval Certificate 39 419 for H11A1Z

**APPLICATIONS**

- Power supply regulators
- Digital logic inputs
- Microprocessor inputs
- Appliance sensor systems
- Industrial controls

**ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> = 25°C Unless Otherwise Specified)**

**TOTAL PACKAGE**

Storage temperature .....	-55°C to 150°C
Operating temperature .....	-55°C to 100°C
Lead temperature (Soldering, 10 sec) .....	260°C
Total package power dissipation at 25°C (LED plus detector) .....	260 mW
Derate linearly from 25°C .....	3.5 mW/°C

**INPUT DIODE**

Forward DC current .....	.60 mA
Reverse voltage .....	.6 V
Peak forward current (1 μs pulse, 300 pps) .....	3.0 A
Power dissipation 25°C ambient .....	100 mW
Derate linearly from 25°C .....	1.8 mW/°C

**OUTPUT TRANSISTOR**

Power dissipation at 25°C .....	150 mW
Derate linearly from 25°C .....	2.67 mW/°C
V <sub>CEO</sub> .....	30 V
V <sub>CE0</sub> .....	70 V
V <sub>ECO</sub> .....	.7 V
Collector current (continuous) .....	100 mA

**H11A1 H11A1Z**

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DT-41-83

**ELECTRO-OPTICAL CHARACTERISTICS (T<sub>A</sub> = 25°C Unless Otherwise Specified)**

TRANSFER CHARACTERISTICS							
	CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
DC	Current Transfer Ratio collector to emitter	CTR	50				I <sub>F</sub> = 10 mA, V <sub>CE</sub> = 10 V
	Saturation voltage	V <sub>CE(SAT)</sub>		0.1	0.4	V	I <sub>F</sub> = 10 mA, I <sub>C</sub> = 0.5 mA
SWITCHING TIMES	Non-saturated Turn-on time	t <sub>on</sub>		2		μs	(V <sub>CE</sub> = V, I <sub>CE</sub> 2 mA, R <sub>L</sub> = 100 Ω) See Figure 9
	Non-saturated Turn-off time	t <sub>off</sub>		2		μs	
	Non-saturated Turn-on time	t <sub>on</sub>		300		ns	(V <sub>CB</sub> = 10 V, I <sub>CB</sub> 50 μA, R <sub>L</sub> = 100 Ω) See Figure 9
	Non-saturated Turn-off time	t <sub>off</sub>		300		ns	
ISOLATION	Isolation voltage	V <sub>iso</sub>	5300			V <sub>AC</sub> RMS	Relative humidity ≤ 50%, I <sub>CO</sub> ≤ 10 μA, 5 seconds
			7500			V <sub>AC</sub> PEAK	Relative humidity ≤ 50%, I <sub>CO</sub> ≤ 10 μA, 5 seconds
	Isolation resistance	R <sub>iso</sub>	10 <sup>11</sup>			ohms	V <sub>I-O</sub> = 500 VDC
	Isolation capacitance	C <sub>iso</sub>		0.5		pF	f = 1 MHz

INDIVIDUAL COMPONENT CHARACTERISTICS							
	CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNITS	TEST CONDITIONS
INPUT DIODE	Forward voltage	V <sub>F</sub>		1.1	1.50	V	I <sub>F</sub> = 10 mA
	Forward voltage temperature coefficient			-1.8		mV/°C	
	Reverse voltage	V <sub>R</sub>	3.0	25		V	I <sub>R</sub> = 10 μA
	Junction capacitance	C <sub>J</sub>		50		pF	V <sub>F</sub> = 0 V, f = 1 MHz
	Reverse leakage current	I <sub>R</sub>		0.35	10	μA	V <sub>R</sub> = 3.0 V
OUTPUT TRANSISTOR	Breakdown voltage Collector to emitter	BV <sub>CEO</sub>	30	45		V	I <sub>C</sub> = 10 mA, I <sub>F</sub> = 0
	Collector to base	BV <sub>CBO</sub>	70	130		V	I <sub>C</sub> = 100 μA, I <sub>F</sub> = 0
	Emitter to collector	BV <sub>ECO</sub>	7	10		V	I <sub>E</sub> = 100 μA, I <sub>F</sub> = 0
	Leakage current Collector to emitter	I <sub>CEO</sub>		5	50	nA	V <sub>CE</sub> = 10 V, I <sub>F</sub> = 0
	Collector to base	I <sub>CBO</sub>			20	nA	V <sub>CB</sub> = 10 V, I <sub>F</sub> = 0
	Capacitance Collector to emitter			8		pF	V <sub>CE</sub> = 0, f = 1 MHz
	Collector to base			20		pF	V <sub>CB</sub> = 5, f = 1 MHz
	Emitter to base			10		pF	V <sub>EB</sub> = 0, f = 1 MHz

ELECTRICAL CHARACTERISTIC CURVES ( $T_A = 25^\circ\text{C}$  Unless Otherwise Specified)

Optocouplers

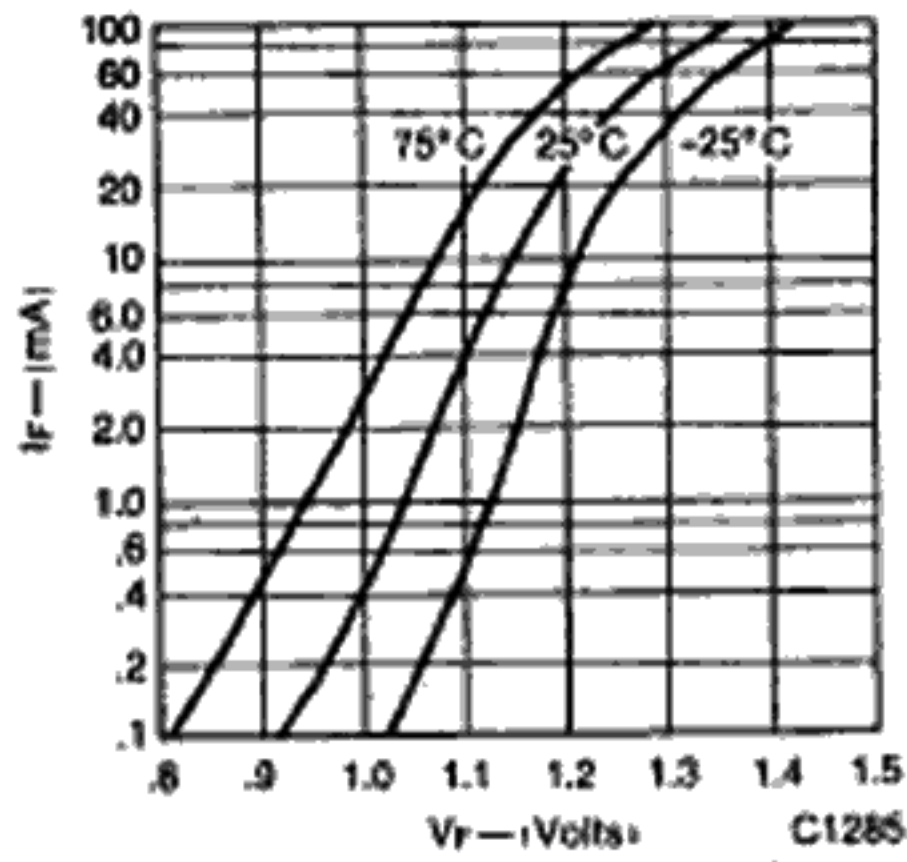


Fig. 1. Forward Voltage vs. Forward Current

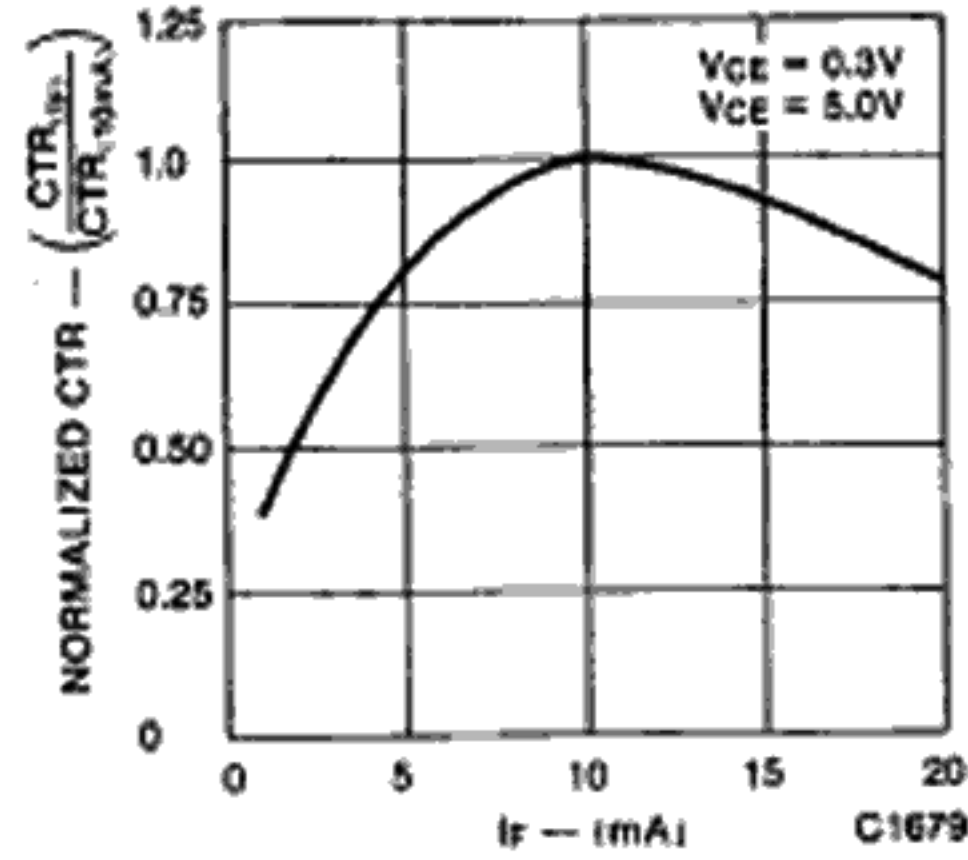


Fig. 2. Normalized Current Transfer Ratio vs. Forward Current

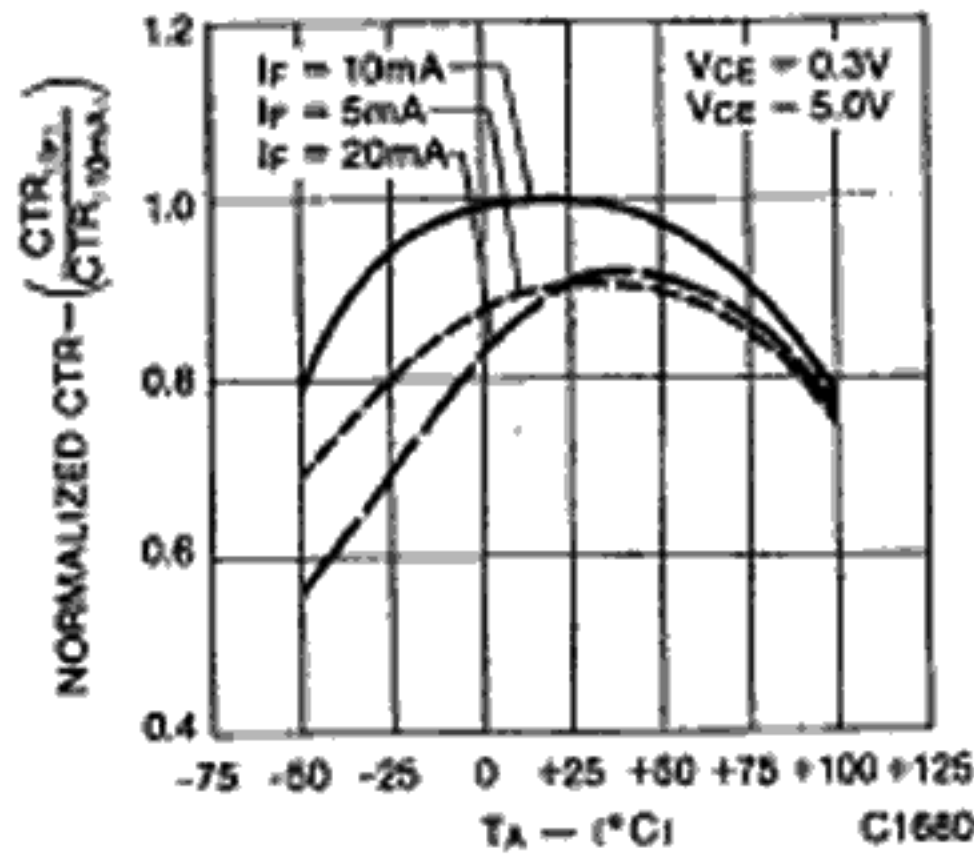


Fig. 3. Normalized Current Transfer Ratio vs. Ambient Temperature

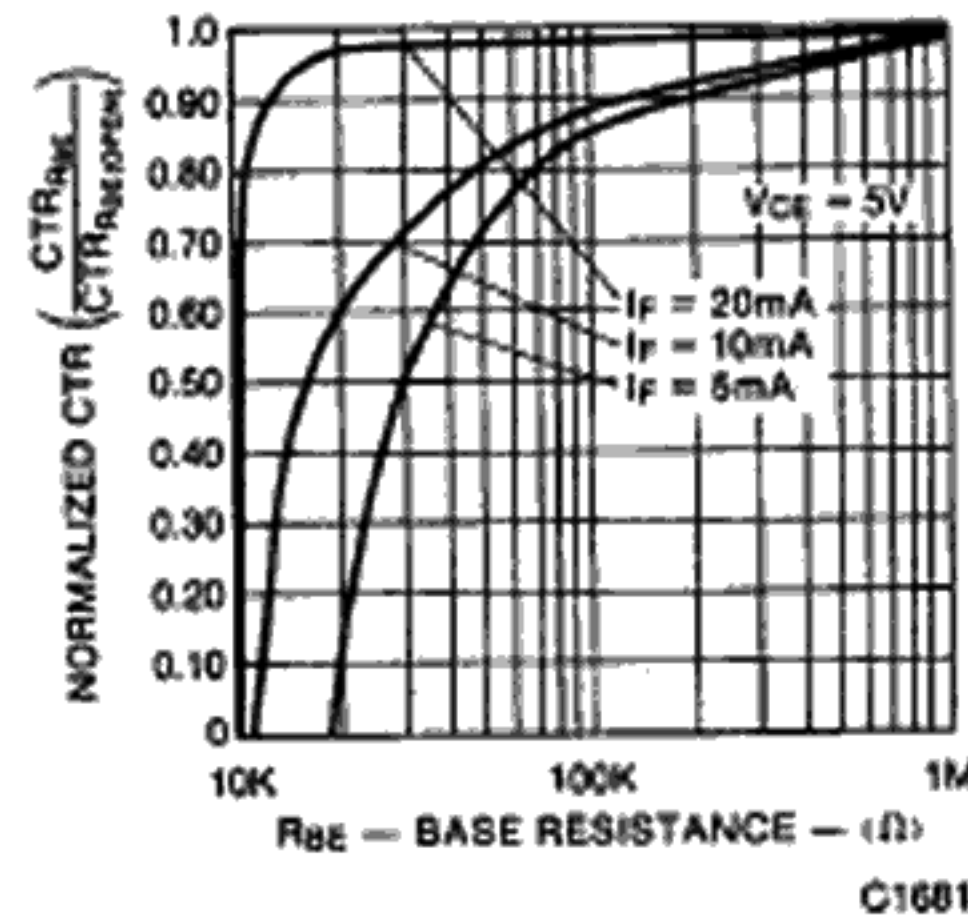


Fig. 4.  $C_{TR}$  vs.  $R_{BE}$

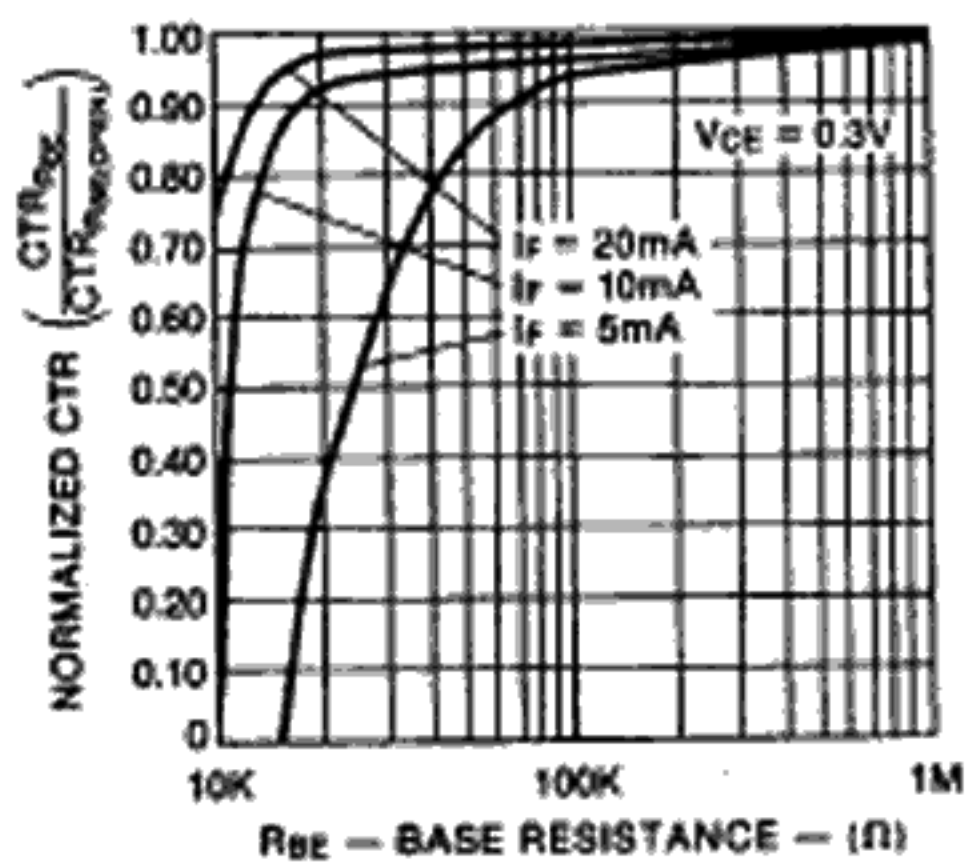


Fig. 5.  $C_{TR}$  vs.  $R_{BE}$

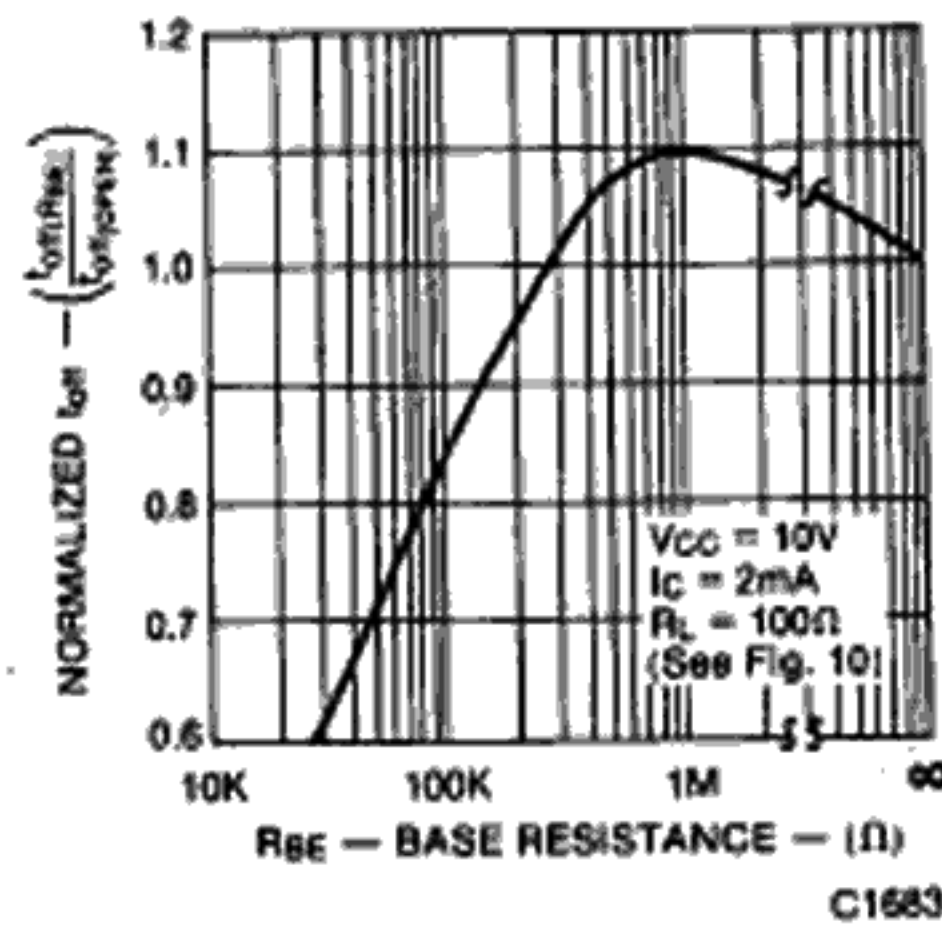
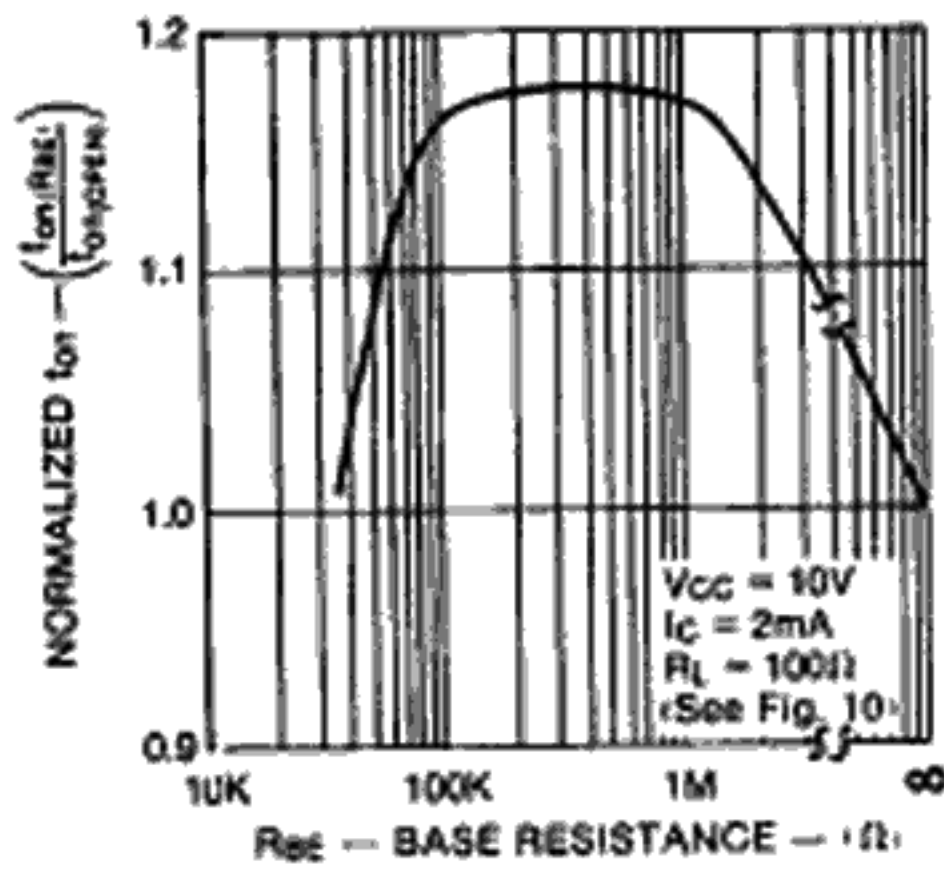


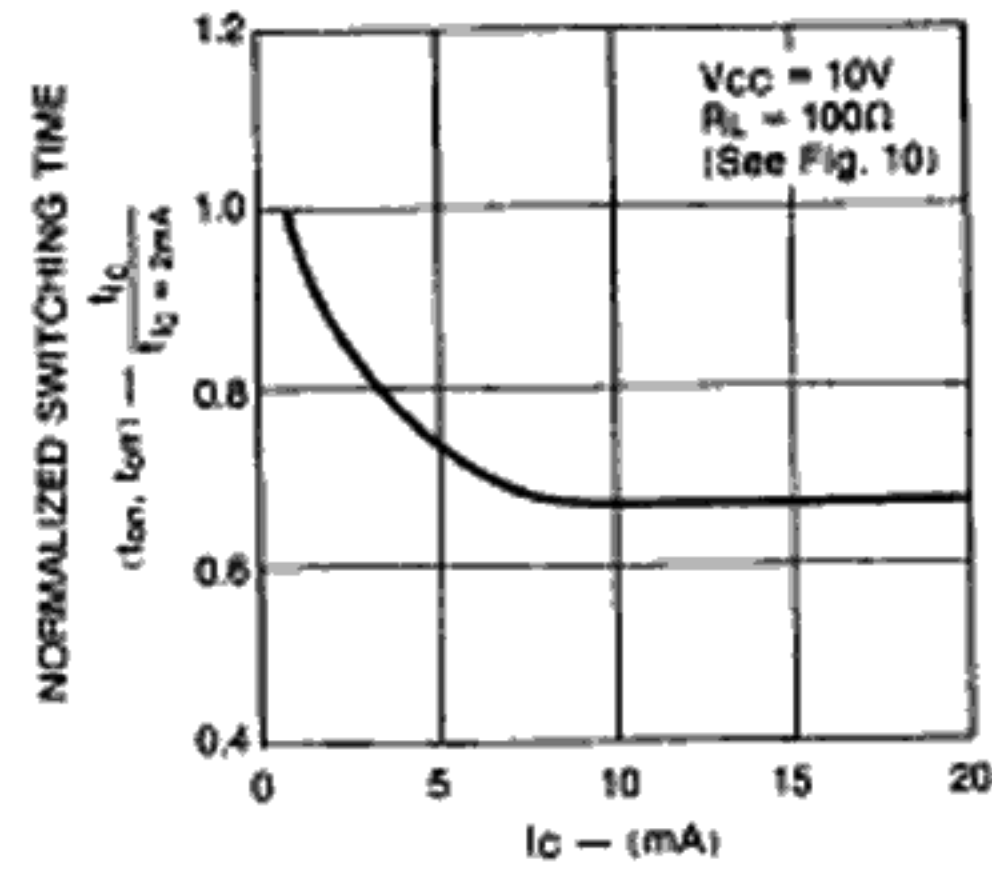
Fig. 6. Normalized  $I_{off}$  vs.  $R_{BE}$

**H11A1 H11A1Z**

**ELECTRICAL CHARACTERISTIC CURVES** (T<sub>A</sub> = 25°C Unless Otherwise Specified)



C1684  
Fig. 7. Normalized I<sub>on</sub> vs. R<sub>Bc</sub>



C1685  
Fig. 8. Normalized Switching Time vs. Collector Current

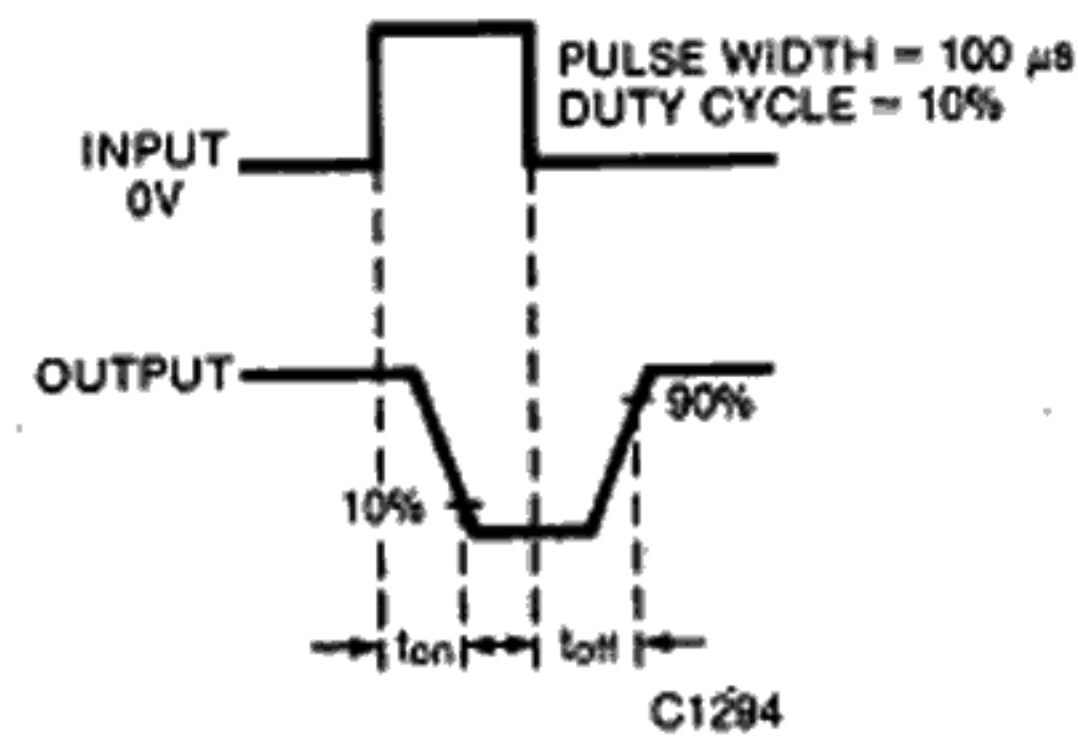
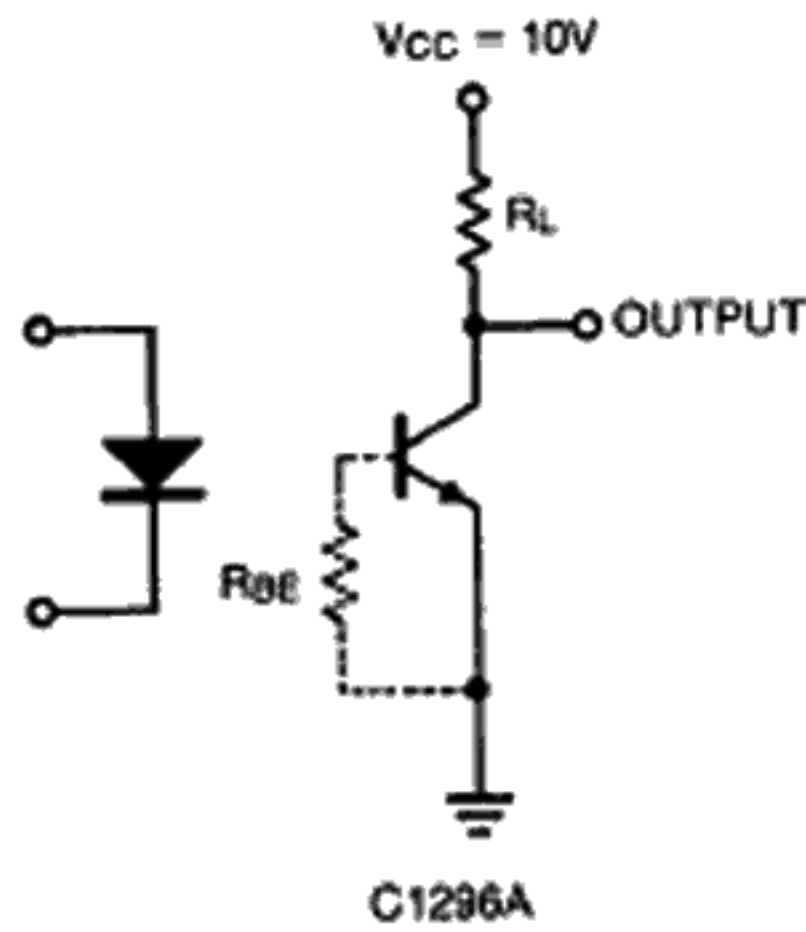


Fig. 9. Switching Time Test Circuit and Waveform